Search Notes			
		<b>e</b> nee iniie (elb)	

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/706,395	ALTUNBASAK ET AL.	
	Examiner	Art Unit	
i	Nhon T. Diep	2621	

SEARCHED			
Class	Subclass	Date	Examiner
	_		
			_
	·		
	<u></u>	<u> </u>	<u> </u>

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
~			
		****	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East text Search	3/28/07	N.D	
		*	